

Certificate of Compliance

Applicant:

Metrix Instruments

8824 Fallbrook Drive

Houston, TX 77064

Model:

Model 5533 Proximity Probe Driver

Project Number:

11652-10

The Metrix Instruments Model 5533 Proximity Probe Driver was tested utilizing the following documents and found to be in compliance with the required criteria on the indicated test date.

EN 61326-1:2006		
CISPR 11: 2003, Radiated Emissions	Group 1, Class A	November 4, 2010
IEC 61000-4-3: 2002	3 V/m (1.4 to 2.0 GHz) 1 V/m (2.0 to 2.7 GHz)	December 1, 2010
PTI EMC Compliance Report		
96-404		

I, Jeffrey A. Lenk, for Professional Testing (EMI), Inc., being familiar with the Electromagnetic Compatibility rules and test procedures, have reviewed the test setup, measured data and this report. I believe them to be true and accurate.

Jeffrey A. Lenk President Lab Code 200062-0

This report has been reviewed and accepted by Metrix Instruments. The undersigned is responsible for ensuring that the Metrix Instruments Model 5533 Proximity Probe Driver will continue to comply with the applicable rules.

Metrix Instruments Representative

11652-10 January 10, 2011

REV: A

Certificate of Compliance

Applicant:

Metrix Instrument Co.

Applicants Address:

1711 Townhurst Drive, Houston, Texas 77043

Model:

5533 Probe Driver

Serial Number:

1021

Project Number:

96-404

The Metrix Instrument Co. 5533 Probe Driver was tested to EN55022 and EN50082-2, and Metrix Instrument Co. Engineering Specifications, utilizing the following documents, and found to be in compliance with the required criteria on the indicated test dates.

EN55022: Emissions Class A January 15, 1996

EN61000-4-2: ESD Level 2 (4/8 kV) January 16, 1996

ENV50140: Radiated Immunity Level 3 (10 V/m) January 16, 1996

EN61000-4-4: EFT Level 3 (2 kV) January 16, 1996

ENV50141: RF Immunity Level 2 (10 V) January 16, 1996

I, Jeffrey A. Lenk for Professional Testing (EMI), Inc., being familiar with the European Community Electromagnetic Compatibility rules and test procedures, have reviewed the test setup, measured data and this report. I believe them to be true and accurate.

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Jeffrey A. Lenk

President

METRIX DOC No: 1163088

REV: A